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(21) International Application Number: PCT/US97/24188 (22) International Filing Date: 29 December 1997 (29.12.97) (30) Priority Data: 08/781,995 6 January 1997 (06.01.97) US (63) Related by Continuation (CON) or Continuation-in-Part (CIP) to Earlier Application US 08/781,995 (CON) Filed on 6 January 1997 (06.01.97) (71) Applicant (for all designated States except US): QUANTUM MATERIALS, INC. [US/US]; 9938 Via Pasar, San Diego, CA 92126 (US). (72) Inventor; and (75) Inventor/Applicant (for US only): FORRAY, Deborah, Derfelt [US/US]; 5190 Biltmore Street, San Diego, CA 92117 (US). (74) Agent: REITER, Stephen, E.; Gray Cary Ware & Freidenrich, Suite 1600, 4365 Executive Drive, San Diego, CA 92121 (US).		(81) Designated States: AL, AM, AT, AU, AZ, BA, BB, BG, BR, BY, CA, CH, CN, CU, CZ, DE, DK, EE, ES, FI, GB, GE, GH, GM, GW, HU, ID, IL, IS, JP, KE, KG, KP, KR, KZ, LC, LK, LR, LS, LT, LU, LV, MD, MG, MK, MN, MW, MX, NO, NZ, PL, PT, RO, RU, SD, SE, SG, SI, SK, SL, TJ, TM, TR, TT, UA, UG, US, UZ, VN, YU, ZW, ARIPO patent (GH, GM, KE, LS, MW, SD, SZ, UG, ZW), Eurasian patent (AM, AZ, BY, KG, KZ, MD, RU, TJ, TM), European patent (AT, BE, CH, DE, DK, ES, FI, FR, GB, GR, IE, IT, LU, MC, NL, PT, SE), OAPI patent (BF, BJ, CF, CG, CI, CM, GA, GN, ML, MR, NE, SN, TD, TG). Published <i>With international search report.</i>
(54) Title: REDUCING VOID FORMATION IN CURABLE ADHESIVE FORMULATIONS (57) Abstract In accordance with the present invention, adhesive formulations have been developed which enable curing of adhesively bonded assemblies (i.e., assemblies which comprise devices which have been adhesively bonded to substrates) with dramatically reduced occurrence of void formation upon curing. In many instances, void formation can be eliminated employing invention compositions. In accordance with another aspect of the present invention, methods employing the above-described adhesive formulations are also provided, as are substantially void-free articles produced thereby. <div style="text-align: right; margin-top: 20px;"><i>2-3 of mal + mixtures</i> <i>11-12 Ex. 1</i> <i>bismal diacetico</i> <i>R130</i> <i>silver flake</i></div>		

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REDUCING VOID FORMATION IN CURABLE ADHESIVE FORMULATIONS

FIELD OF THE INVENTION

The present invention relates to compositions useful for bonding electronic devices to supports therefor, as well as methods for achieving the desired bonding and
5 substantially void-free articles produced thereby.

BACKGROUND OF THE INVENTION

The micro-electronics industry uses various substrates for the attachment of microelectronic devices thereto. Most of these devices are attached to suitable
10 substrates using some kind of adhesive material. Unfortunately, many of the substrates and/or devices commonly used in the micro-electronics industry tend to absorb moisture. When subjected to the elevated temperatures required to cure such adhesive materials,
15 various levels of void formation can occur as a result of the release of absorbed moisture and/or other volatile materials which may be released by the device and/or substrate at elevated temperatures.

The formation of voids can lead to a severe
20 reduction in the reliability of the resulting article, due to disruption of the adhesive interface between the device and substrate. It would be desirable, therefor, to develop compositions and methods for the use thereof which allow the assembly and adhesion of device to substrate without
25 the creation of substantial level of voids in the finished article.

BRIEF DESCRIPTION OF THE INVENTION

In accordance with the present invention, adhesive formulations have been developed which enable curing of adhesively bonded assemblies (i.e., assemblies
5 which comprise devices which have been adhesively bonded to substrates) with dramatically reduced occurrence of void formation upon curing. In many instances, void formation can be eliminated employing invention compositions.

In accordance with another aspect of the present
10 invention, methods employing the above-described adhesive formulations are also provided, as are substantially void-free articles produced thereby.

DETAILED DESCRIPTION OF THE INVENTION

In accordance with the present invention, there
15 are provided methods to reduce void formation upon curing of an adhesive formulation employed to bond a device to a substrate, wherein said device and/or said substrate are prone to release volatiles at elevated temperatures. Invention methods comprise using as a curing catalyst for
20 such adhesive formulations a catalyst which initiates curing of the formulation at a temperature of less than about 100°C.

Adhesive formulations contemplated for use in the practice of the present invention include cyanate ester-
25 based formulations, maleimide-based formulations, epoxy-based formulations, (meth)acrylate-based formulations, vinyl ether-based formulations, vinyl ester-based formulations, allyl ester-based formulations, diallyl amide-based formulations, propargyl ether-based
30 formulations, formulations based on a polysiloxane backbone terminated with one or more of the above-described functional groups, formulations based on a preimidized

polyimide backbone terminated with one or more of the above-described functional groups, and the like, as well as mixtures of any two or more thereof.

A wide variety of cyanate ester-based
5 formulations are suitable for use in the practice of the present invention. Numerous examples of such formulations have been described in the art. See, for example, U.S. Patent No. 5,447,988, U.S. Patent No. 5,358,992, U.S. Patent No. 5,489,641, each of which are hereby incorporated
10 by reference herein in their entirety.

A wide variety of maleimide-based formulations are suitable for use in the practice of the present invention. Numerous examples of such formulations have been described in the art. See, for example, United States
15 Serial No. 08/300,721, filed September 2, 1994, United States Serial No. 08/460,495, filed June 2, 1995, United States Serial No. 08/711,982, filed September 10, 1996, U.S. Patent No. 4,806,608, and U.S. Patent No. 4,581,461, each of which are hereby incorporated by reference herein
20 in their entirety.

A wide variety of thermally curable (i.e., thermoset) epoxy-based formulations are suitable for use in the practice of the present invention. Numerous examples of such formulations have been described in the art. See,
25 for example, U.S. Patent No. 5,158,780 and U.S. Patent No. 5,043,102, each of which are hereby incorporated by reference herein in their entirety.

A wide variety of (meth)acrylate-based formulations are suitable for use in the practice of the
30 present invention. Numerous examples of such formulations have been described in the art. See, for example, U.S. Patent No. 5,043,102, hereby incorporated by reference herein in its entirety.

A wide variety of vinyl ether-based formulations are suitable for use in the practice of the present invention. Numerous examples of such formulations have been described in the art. See, for example, United States
5 Serial No. 08/460,495, filed June 2, 1995, which is hereby incorporated by reference herein in its entirety.

A wide variety of vinyl ester-based formulations are suitable for use in the practice of the present invention. Numerous examples of such formulations have
10 been described in the art. See, for example, U.S. Patent No. 5,475,048, which is hereby incorporated by reference herein in its entirety.

A wide variety of allyl ester-based formulations are suitable for use in the practice of the present
15 invention. Numerous examples of such formulations have been described in the art. See, for example, U.S. Patent No. 5,475,048, which is hereby incorporated by reference herein in its entirety.

A wide variety of diallyl amide-based
20 formulations are suitable for use in the practice of the present invention. Numerous examples of such formulations have been described in the art. See, for example, each of which are hereby incorporated by reference herein in their entirety.

A wide variety of propargyl ether-based
25 formulations are suitable for use in the practice of the present invention. Numerous examples of such formulations have been described in the art. See, for example, United States Serial No. 08/684,148, filed July 19, 1996, which is
30 hereby incorporated by reference herein in its entirety.

Presently preferred adhesive formulations contemplated for use in the practice of the present invention comprise a mixture of maleimide and vinyl ether.

Optionally, adhesive formulations contemplated
5 for use in the practice of the present invention further
comprise at least one filler. Fillers contemplated for use
herein include electrically conductive and thermally
conductive materials, as well as non-conductive materials,
which impart insulating properties to the resulting
10 formulation.

Examples of electrically conductive fillers
contemplated for use herein include silver, nickel, cobalt,
copper, aluminum, metal-coated graphite fibers (e.g.,
employing such metals as nickel, silver, copper, and the
15 like as the metal coating), and the like, as well as
mixtures thereof. The presently preferred electrically
conductive filler contemplated for use herein is silver.
Both powder and flake forms of filler may be used in the
attach paste compositions of the present invention. The
20 preferred thickness of flake is under 2 microns with a
dimension of about 20 to about 25 microns. Flake
contemplated for use herein preferably has a surface area
of about 0.15 to 5.0 m²/g and a tap density of 0.4 to 5.5
g/cc. Powder contemplated for use herein preferably has a
25 diameter of about 0.5 to 15 microns.

Thermally conductive fillers contemplated for use
in the practice of the present invention include diamond,
boron nitride, alumina, aluminum nitride, silicon carbide,
magnesium oxide, and the like, as well as mixtures of any
30 two or more thereof.

Catalysts contemplated for use in the practice of
the present invention are those which initiate curing of
the adhesive formulation at a desirably low temperature,

and which also promote curing of adhesive formulations at a sufficiently rapid rate such that the cure peak maximum similarly occurs at a desirably low temperature, e.g., at a temperature of no greater than about 100°C. Presently
5 preferred catalysts contemplated for use herein are those which promote curing of adhesive formulations at a rate such that the cure peak maximum occurs at a temperature of no greater than about 90°C. Especially preferred catalysts contemplated for use herein are those which promote curing
10 of adhesive formulations at a rate such that the cure peak maximum occurs at a temperature of no greater than about 80°C.

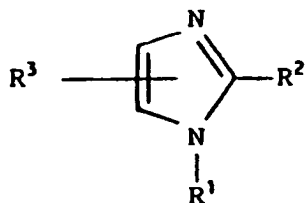
Even more preferred for use herein are catalysts which promote curing of adhesive formulations at a rate
15 such that the cure peak maximum occurs at a temperature of no greater than about 70°C, with catalysts which promote curing of adhesive formulations at a rate such that the cure peak maximum occurs at a temperature of no greater than about 60°C being especially preferred with certain
20 adhesive formulations.

Catalysts contemplated for use in the practice of the present invention include free radical catalysts, anionic cure catalysts, cationic cure catalysts, transition metal catalysts, and the like, as well as combinations of
25 any two or more thereof.

Exemplary free radical catalysts contemplated for use in the practice of the present invention include peroxy esters, peroxy carbonates, hydroperoxides, alkylperoxides, arylperoxides, and the like. Specific free radical
30 initiators contemplated for use herein include cumyl peroxyneodecanoate, cumyl peroxyneoheptanoate, tert-amyl peroxyneodecanoate, tert-butyl peroxyneodecanoate, tert-amyl peroxyneoheptanoate, tert-butyl peroxyneoheptanoate, a peroxydicarbonate, 2,4,4-trimethylpentyl-2-

peroxyneodecanoate, di(n-propyl) peroxydicarbonate,
 di-(sec-butyl) peroxydicarbonate, di-(4-tert-
 butylcyclohexyl) peroxydicarbonate, di-(2-ethylhexyl)
 peroxydicarbonate, dimyristyl peroxydicarbonate, tert-amyl
 5 peroxy pivalate, tert-butyl peroxy pivalate, di-[3,5,5-
 trimethylhexanoyl] peroxide, decanoyl peroxide, lauroyl
 peroxide, dilauroyl peroxide, di-isononanoyl peroxide,
 2,5-dimethyl-2,5-di(2-ethylhexanoylperoxy) hexane, 1-amyl
 peroxy 2-ethylhexanoate, and the like, as well as
 10 combinations of any two or more thereof.

Exemplary anionic cure catalysts contemplated for
 use in the practice of the present invention include
 imidazoles, tertiary amines, and the like. Imidazoles
 contemplated for use herein are those having the generic
 15 structure:



wherein:

R¹ is selected from the group consisting of
 alkyl, aryl and cyano moieties;

R² is selected from the group consisting of
 25 alkyl, aryl and cyano moieties; and

R³ is selected from the group consisting of
 alkyl, substituted alkyl, alkylaryl and
 substituted alkylaryl moieties.

As employed herein, "alkyl" refers to straight or
 30 branched chain alkyl radicals having in the range of about
 1 up to 12 carbon atoms; "substituted alkyl" refers to
 alkyl radicals further bearing one or more substituents
 such as hydroxy, alkoxy (of a lower alkyl group), mercapto
 (of a lower alkyl group), aryl, heterocyclic, halogen,

trifluoromethyl, cyano, nitro, amino, carboxyl, carbamate, sulfonyl, sulfonamide, and the like.

As employed herein, "aryl" refers to aromatic radicals having in the range of 6 up to 14 carbon atoms and
5 "substituted aryl" refers to aryl radicals further bearing one or more substituents as set forth above.

As employed herein "alkylaryl" refers to alkyl-substituted aryl radicals and "substituted alkylaryl" refers to alkylaryl radicals further bearing one or more
10 substituents as set forth above.

Exemplary imidazoles contemplated for use herein include 2-ethyl-4-methyl imidazole, 1-methyl imidazole, 2-methyl imidazole, 2-undecyl imidazole, 2-phenyl imidazole, and the like.

15 Tertiary amines contemplated for use herein include hexadecyl-dimethylamine, dihexadecylmethylamine, octadecyldimethyl-amine, dioctadecylmethylamine, dimethylbehenylamine, dimethyleicosylamine, N,N,N'-trimethyl-N'-hexadecyl-1,2-diaminoethane, N,N,N'-trimethyl-
20 N'-octadecyl-1,2-diamino-ethane, N,N,N'-trimethyl-N'-eicosyl-1,2-diaminoethane, N,N,N'-trimethyl-N'-behenyl-1,2-diaminoethane, N,N,N',N'-tetramethyl-1,20-diamino-(10,11-dioctyl)-eicosane, and the like, as well as mixtures of any two or more thereof.

25 Exemplary cationic cure catalysts contemplated for use in the practice of the present invention include onium salts, iodonium salts, sulfonium salts, and the like.

Exemplary transition metal catalysts contemplated for use in the practice of the present invention include
30 nickel, copper, cobalt and the like, in the form of a chelate, a soap, or the like.

Generally in the range of about 0.005 up to 10 wt % of at least one of the above-described catalysts (based on the total weight of the organic phase, i.e., absent any filler) will be employed, with in the range of about 0.01 up to 5 wt % being presently preferred.

As readily recognized by those of skill in the art, a wide variety of devices can be bonded in accordance with the present invention. Examples of such devices include silicon-based microelectronic devices, gallium arsenide-based microelectronic devices, quartz-based microelectronic devices, sapphire-based microelectronic devices, indium phosphide-based microelectronic devices, cadmium sulfide-based microelectronic devices, lithium niobate-based microelectronic devices, and the like.

Those of skill in the art also readily recognize that a variety of substrates can be bonded in accordance with the present invention. Examples of such substrates are boards made of materials which tend to release volatiles upon exposure to elevated temperatures, e.g., boards made of materials which tend to absorb water. Examples of such boards include bismaleimide-triazine boards, epoxy boards, boards having a polyimide film thereon, boards having a polycarbonate film thereon, boards having a solder mask coating thereon, and the like.

In accordance with another embodiment of the present invention, there are provided adhesive compositions useful for attaching a device to a substrate, wherein said device and/or said substrate are prone to release volatiles at elevated temperatures, and wherein there is substantially no void formation upon curing thereof. Invention compositions comprise:

vehicle, and

a catalyst which initiates curing of said vehicle at a temperature of no greater than 100°C.

Vehicles contemplated for use in the practice of the present invention include cyanate ester-based formulations, maleimide-based formulations, epoxy-based formulations, (meth)acrylate-based formulations, vinyl ether-based formulations, vinyl ester-based formulations, allyl ester-based formulations, diallyl amide-based formulations, propargyl ether-based formulations, formulations based on a polysiloxane backbone terminated with one or more of the above-described functional groups, formulations based on a preimidized polyimide backbone terminated with one or more of the above-described functional groups, and the like, as well as mixtures of any two or more thereof, as described hereinabove.

Similarly, catalysts contemplated for use in the preparation of invention compositions are as described above, and such catalysts can be added to invention composition in amounts as set forth above.

In accordance with yet another embodiment of the present invention, there are provided substantially void-free articles prepared according to the above-described method. Such articles comprise a device attached to a substrate, wherein the device and/or the substrate are prone to release volatiles at elevated temperatures, and wherein the bond between the device and the substrate is substantially void-free.

As used herein, "substantially void-free" refers to a substantially continuous bond of adhesive between the interconnected device and substrate. Voids manifest as a disruption of this otherwise continuous bond and compromise both the strength of the resulting bond, and the ability of

such bond to resist the influence of outside forces, such as high moisture levels, high shear forces, and the like.

The invention will now be described in greater detail by reference to the following non-limiting examples.

5

Example 1

A resin system was prepared for testing, using a base formulation as follows, and various different catalysts, to determine the effect of catalyst choice on the occurrence of voids upon curing. The base resin
10 composition employed comprises:

- 60 parts by wt of the bismaleimide, 1,20-
bismaleimido-10,11-dioctyl-eicosane,
- 30 parts by wt of maleated polybutadiene R130
MA20 from Ricon Resins, Grand Junction, CO),
- 15 22 parts by wt of a branched, C₂₄ monovinyl ether
(i.e., the monovinyl ether of 2-decyl
tetradecanol),
- 4 parts by wt of a coupling agent (e.g., 3 parts
of A-186 (i.e., β -(3,4-epoxycyclohexyl)
20 ethyl trimethoxysilane) and one part of
A-174 (i.e., γ -methacryloxypropyl
trimethoxysilane), both of which are
available from OSi Specialities, Endicott,
NY), and
- 25 1, 3 or 5 parts by wt of a catalyst.

Catalysts employed herein include Perkadox 16S
(di-(4-tert-butylcyclohexyl)peroxydicarbonate, available
from Akzo Nobel), Trigonox 141 (2,5-dimethyl-2,5-di-(2-
ethylhexanoylperoxy)hexane, available from Akzo Nobel), and
30 Witco USP90MD (1,1-bis(tert-amylperoxy)cyclohexane,
available from Witco Chemical). Each of these catalysts
has a 10 hour decomposition half life of 70°C or less, and

were added to the base formulation described above at levels of 1, 3 or 5 parts by wt. Thus, nine pastes were made for testing, each filled with 77 wt % silver flake. A differential scanning calorimetr (DSC) and a void test
5 was performed on each paste.

The void test was performed using a copper-clad BT (bismaleimide-triazine) resin with Taiyo PSR 4000 version AUS5 solder mask. The substrate was placed in an 85/85 chamber for 15-16 hours to insure that moisture
10 absorption would be evident. The nine plates were attached to the substrate using a glass cover slide 300x300 mils. The pastes were cured at 150°C for 60 seconds on a hot plate apparatus.

The DSC was performed at a ramp rate of 10°C/min.
15 The sample size used was about 20-30 mg. Analysis of the DSC shows the onset of cure, the cure peak maximum and the total energy evolved. The cure onset temperature and the cure peak maximum temperature are presented in the Table for each of the pastes.

Table

Paste*	Cure onset, °C	Cure peak, °C	% Voids
A	84.20	90.46	0
B	77.38	82.28	0
C	74.04	78.90	0
D	102.62	113.15	100
E	95.08	103.74	100
F	90.13	99.16	0
G	117.79	129.08	100
H	111.66	122.43	100
I	109.32	118.97	100

- * Pastes A, B and C contain 1, 3 and 5 parts by wt, respectively, of Perkadox 16S;
Pastes D, E and F contain 1, 3 and 5 parts by wt, respectively, of Trigonox 141; and
Pastes G, H and I contain 1, 3 and 5 parts by wt, respectively, of Witco USP90MD.

The results presented above demonstrate that voiding under the die does not occur with moisture sensitive polymers so long as the cure onset and cure peak maximum temperatures are both below 100°C.

While the invention has been described in detail with reference to certain preferred embodiments thereof, it will be understood that modifications and variations are within the spirit and scope of that which is described and claimed.

That which is claimed is:

1. A method to reduce void formation upon curing of an adhesive formulation employed to bond a device to a substrate, wherein said device and/or said substrate are prone to release volatiles at elevated temperatures, said method comprising using as a curing catalyst for said formulation a catalyst which initiates curing of said formulation at a temperature of less than 100°C.

2. A method according to claim 1 wherein said catalyst promotes curing of said formulation at a rate such that the cure peak maximum occurs at a temperature of no greater than about 100°C.

3. A method according to claim 1 wherein said catalyst is a free radical catalyst, an anionic cure catalyst, a cationic cure catalyst, a transition metal catalyst, or a combination of any two or more thereof.

4. A method according to claim 3 wherein said free radical catalyst is selected from the group consisting of cumyl peroxyneodecanoate, cumyl peroxyneoheptanoate, tert-amyl peroxyneodecanoate, tert-butyl peroxyneodecanoate, tert-amyl peroxyneoheptanoate, tert-butyl peroxyneoheptanoate, a peroxydicarbonate, 2,4,4-trimethylpentyl-2-peroxyneodecanoate, di(n-propyl) peroxydicarbonate, di-(sec-butyl) peroxydicarbonate, di-(4-tert-butylcyclohexyl) peroxydicarbonate, di-(2-ethylhexyl) peroxydicarbonate, dimyristyl peroxydicarbonate, tert-amyl peroxy-pivalate, tert-butyl peroxy-pivalate, di-[3,5,5-trimethylhexanoyl] peroxide, decanoyl peroxide, lauroyl peroxide, dilauroyl peroxide, di-isononanoyl peroxide, 2,5-dimethyl-2,5-di(2-ethylhexanoylperoxy) hexane and 1-amyl peroxy 2-ethylhexanoate.

5. A method according to claim 1 wherein said catalyst promotes curing of said formulation at a rate such that the cure peak maximum occurs at a temperature of no greater than about 90°C.

6. A method according to claim 1 wherein said catalyst promotes curing of said formulation at a rate such that the cure peak maximum occurs at a temperature of no greater than about 80°C.

7. A method according to claim 1 wherein said catalyst promotes curing of said formulation at a rate such that the cure peak maximum occurs at a temperature of no greater than about 70°C.

8. A method according to claim 1 wherein said catalyst promotes curing of said formulation at a rate such that the cure peak maximum occurs at a temperature of no greater than about 60°C.

9. A method according to claim 1 wherein said adhesive formulation is a cyanate ester-based formulation, a maleimide-based formulation, an epoxy-based formulation, a (meth)acrylate-based formulation, a vinyl ether-based
5 formulation, a vinyl ester-based formulation, an allyl ester-based formulation, a diallyl amide-based formulation a propargyl ether-based formulation, formulations based on a polysiloxane backbone terminated with one or more of the above-described functional groups, formulations based on a
10 preimidized polyimide backbone terminated with one or more of the above-described functional groups, or a mixture of any two or more thereof.

10. A method according to claim 9 wherein said adhesive formulation comprises a mixture of maleimide and vinyl ether.

11. A method according to claim 9 wherein said adhesive formulation further comprises at least one filler.

12. A method according to claim 1 wherein said device is a silicon-based microelectronic device, a gallium arsenide-based microelectronic device, a quartz-based microelectronic device, a sapphire-based microelectronic device, an indium phosphide-based microelectronic device, a cadmium sulfide-based microelectronic device, or a lithium niobate-based microelectronic device.

13. A method according to claim 1 wherein said substrate is a board which releases volatiles upon exposure to elevated temperatures.

14. A method according to claim 13 wherein said substrate is a bismaleimide-triazine board, an epoxy board, a board having a polyimide film thereon, a board having a polycarbonate film thereon, or a board having a solder mask coating thereon.

15. An adhesive composition useful for attaching a device to a substrate, wherein said device and/or said substrate are prone to release volatiles at elevated temperatures, and wherein there is substantially no void formation upon curing thereof, said composition comprising:
vehicle, and
a catalyst which initiates curing of said vehicle at a temperature of no greater than 100°C.

16. A composition according to claim 15 wherein said catalyst promotes curing of said composition at a rate such that the cure peak maximum occurs at a temperature of no greater than about 100°C.

17. A composition according to claim 15 wherein said catalyst is a free radical catalyst, an anionic cure catalyst, a cationic cure catalyst, a transition metal catalyst, or a combination of any two or more thereof.

18. A composition according to claim 17 wherein said free radical catalyst is selected from the group consisting of cumyl peroxyneodecanoate, cumyl peroxyneoheptanoate, tert-amyl peroxyneodecanoate, tert-butyl peroxyneodecanoate, tert-amyl peroxyneoheptanoate, tert-butyl peroxyneoheptanoate, a peroxydicarbonate, 2,4,4-trimethylpentyl-2-peroxyneodecanoate, di(n-propyl) peroxydicarbonate, di-(sec-butyl) peroxydicarbonate, di-(4-tert-butylcyclohexyl) peroxydicarbonate, di-(2-ethylhexyl) peroxydicarbonate, dimyristyl peroxydicarbonate, tert-amyl peroxy-pivalate, tert-butyl peroxy-pivalate, di-[3,5,5-trimethylhexanoyl] peroxide, decanoyl peroxide, lauroyl peroxide, dilauroyl peroxide, di-isononanoyl peroxide, 2,5-dimethyl-2,5-di(2-ethylhexanoylperoxy) hexane and 1-amyl peroxy 2-ethylhexanoate.

19. A composition according to claim 15 wherein said catalyst promotes curing of said formulation at a rate such that the cure peak maximum occurs at a temperature of no greater than about 90°C.

20. A composition according to claim 15 wherein said catalyst promotes curing of said formulation at a rate such that the cure peak maximum occurs at a temperature of no greater than about 80°C.

21. A composition according to claim 15 wherein said catalyst promotes curing of said formulation at a rate such that the cure peak maximum occurs at a temperature of no greater than about 70°C.

22. A composition according to claim 15 wherein said catalyst promotes curing of said formulation at a rate such that the cure peak maximum occurs at a temperature of no greater than about 60°C.

23. A composition according to claim 15 wherein said vehicle is a cyanate ester-based formulation, a maleimide-based formulation, an epoxy-based formulation, a (meth)acrylate-based formulation, a vinyl ether-based
5 formulation, a vinyl ester-based formulation, an allyl ester-based formulation, a diallyl amide-based formulation a propargyl ether-based formulation, formulations based on a polysiloxane backbone terminated with one or more of the above-described functional groups, formulations based on a
10 preimidized polyimide backbone terminated with one or more of the above-described functional groups, or a mixture of any two or more thereof.

24. A composition according to claim 15 wherein said vehicle comprises a mixture of maleimide and vinyl ether.

25. A composition according to claim 15 wherein said composition further comprises at least one filler.

26. A substantially void-free article prepared according to the method of claim 1.

27. An article comprising a device attached to a substrate, wherein said device and/or said substrate are prone to release volatiles at elevated temperatures, and wherein the bond between said device and said substrate is substantially void-free.

INTERNATIONAL SEARCH REPORT

International application No.

PCT/US97/24188

A. CLASSIFICATION OF SUBJECT MATTER

IPC(6) : C09J 5/02

US CL : 156/307.3

According to International Patent Classification (IPC) or to both national classification and IPC

B. FIELDS SEARCHED

Minimum documentation searched (classification system followed by classification symbols)

U.S. : 29/832; 156/87, 307.3

Documentation searched other than minimum documentation to the extent that such documents are included in the fields searched

Electronic data base consulted during the international search (name of data base and, where practicable, search terms used)

C. DOCUMENTS CONSIDERED TO BE RELEVANT

Category*	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
X — Y	US 4,312,692 A (IKEDA ET AL) 26 January 1982. See Figs. 6-8, Abstract, col. 1 lines 13-22, and 67-68, col. 2 lines 1-2, col. 3 lines 12-33, col. 4 lines 6-17.	1-27 — 1-27
X — Y	US, 4,916,805 A (ELLRICH ET AL) 17 April 1990, see Abstract, col. 1 lines 7-28, col. 2 lines 10-18, 59-60 and 67-68, col. 4 line 20 thru col. 6 line 59, col. 6 line 66 thru col. 7 line 3.	1-27 — 1-27
X —,P Y	US, 5,644,837 A (FATHI ET AL) 08 July 1997, see Fig. 1, Abstract, col. 1 lines 13-16 and 34-40, col. 3 lines 2-5, col. 4 lines 53-63, col. 5 line 46 thru col. 6 line 5.	1-27 — 1-27



Further documents are listed in the continuation of Box C.



See patent family annex.

Special categories of cited documents:	
A document defining the general state of the art which is not considered to be of particular relevance	*T* later document published after the international filing date or priority date and not in conflict with the application but cited to understand the principle or theory underlying the invention
B earlier document published on or after the international filing date	*X* document of particular relevance; the claimed invention cannot be considered novel or cannot be considered to involve an inventive step when the document is taken alone
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O document referring to an oral disclosure, use, exhibition or other means	*A* document member of the same patent family
P document published prior to the international filing date but later than the priority date claimed	

Date of the actual completion of the international search

17 FEBRUARY 1998

Date of mailing of the international search report

19 MAR 1998

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